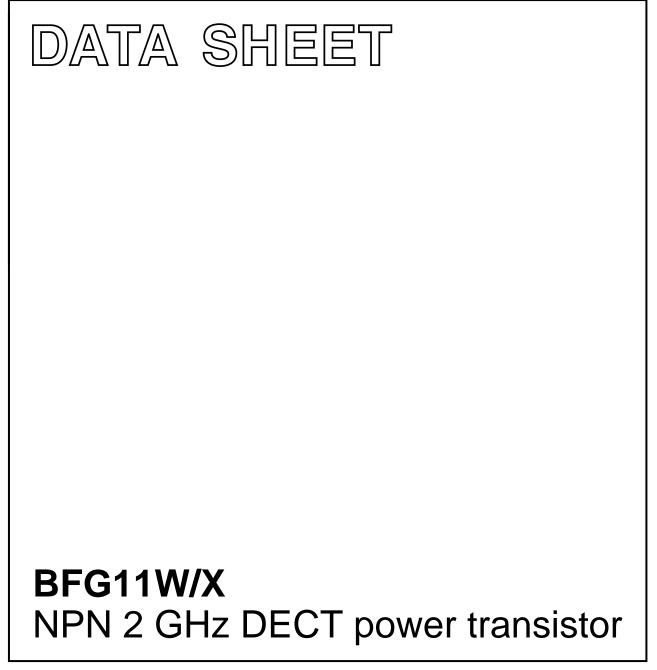
DISCRETE SEMICONDUCTORS



Preliminary specification File under Discrete Semiconductors, SC14 1995 Sep 22



#### FEATURES

- High power gain
- High efficiency
- Small size discrete power amplifier
- 1.9 GHz operating area
- Gold metallization ensures excellent reliability.

#### APPLICATIONS

• Common emitter class-AB operation in handheld radio equipment at 1.9 GHz.

#### QUICK REFERENCE DATA

RF performance at Ts  $\leq$  60 °C in a common-emitter test circuit.

MODE OF OPERATION	f	V <sub>CE</sub>	P <sub>L</sub>	G <sub>p</sub>	η <sub>c</sub>
	(GHz)	(V)	(mW)	(dB)	(%)
Pulsed, class-AB, duty cycle: < 1 : 2; $t_p$ = 10 ms	1.9	3.6	400	≥6	≥50

#### LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

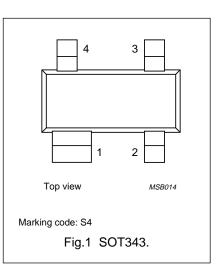
SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>CBO</sub>	collector-base voltage	open emitter	-	20	V
V <sub>CEO</sub>	collector-emitter voltage	open base	-	8	V
V <sub>EBO</sub>	emitter-base voltage	open collector	-	2.5	V
I <sub>C(AV)</sub>	collector current (DC)		-	500	mA
P <sub>tot</sub>	total power dissipation	up to T <sub>s</sub> = 60 °C; note 1	-	630	mW
T <sub>stg</sub>	storage temperature		-65	+150	°C
Tj	junction temperature		-	175	°C

#### DESCRIPTION

NPN silicon planar epitaxial transistor encapsulated in a plastic SOT343 package.

#### PINNING

PIN	DESCRIPTION		
BFG11/X (see Fig.1)			
1	collector		
2	emitter		
3	base		
4	emitter		



### BFG11W/X

## BFG11W/X

#### THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R <sub>th j-s</sub>	thermal resistance from junction to soldering point	up to $T_s = 60 \text{ °C}$ ; note 1; P <sub>tot</sub> = 630 mW	180	K/W

#### Note to the Limiting values and Thermal characteristics

1.  $T_s$  is the temperature at the soldering point of the collector pin.

#### CHARACTERISTICS

 $T_i = 25 \ ^{\circ}C$  unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>(BR)CBO</sub>	collector-base breakdown voltage	open emitter; I <sub>C</sub> = 0.1 mA	20	_	V
V <sub>(BR)CEO</sub>	collector-emitter breakdown voltage	open base; I <sub>C</sub> = 10 mA	8	_	V
V <sub>(BR)EBO</sub>	emitter-base breakdown voltage	open collector; I <sub>E</sub> = 0.1 mA	2.5	_	V
I <sub>CES</sub>	collector cut-off current	$V_{CE} = 8 V; V_{BE} = 0$	-	100	μA
h <sub>FE</sub>	DC current gain	I <sub>C</sub> = 100 mA; V <sub>CE</sub> = 5 V	25	-	
C <sub>c</sub>	collector capacitance	I <sub>E</sub> = i <sub>e</sub> = 0; V <sub>CB</sub> = 3.6 V; f = 1 MHz	_	5	pF
C <sub>re</sub>	feedback capacitance	I <sub>C</sub> = 0; V <sub>CE</sub> = 3.6 V; f = 1 MHz	_	4	pF

#### **APPLICATION INFORMATION**

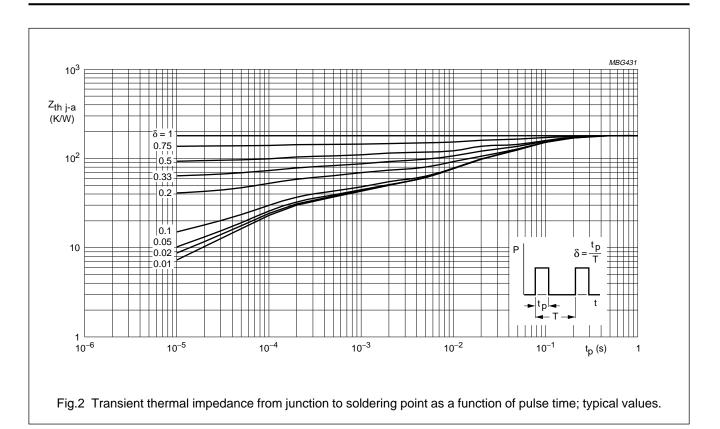
RF performance at  $T_s \le 60$  °C in a common-emitter test circuit.

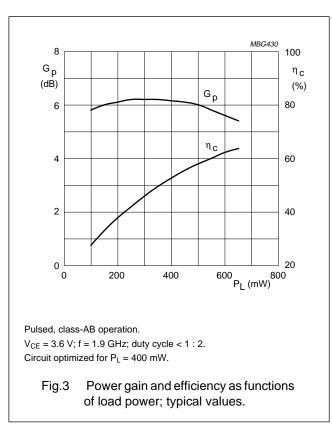
MODE OF OPERATION	f	V <sub>CE</sub>	l <sub>CQ</sub>	P <sub>L</sub>	G <sub>p</sub>	η <sub>c</sub>
	(GHz)	(V)	(mA)	(mW)	(dB)	(%)
Pulsed, class-AB, duty cycle: < 1 : 2; $t_p = 10 \text{ ms}$	1.9	3.6	1	400	>6	>50

#### **Ruggedness in class-AB operation**

The transistors are capable of withstanding a load mismatch corresponding to VSWR = 10 : 1 through all phases, at rated output power under pulsed conditions up to a supply voltage of 5.5 V, f = 1.9 GHz and a duty cycle of 1 : 2,  $t_p = 10$  ms.

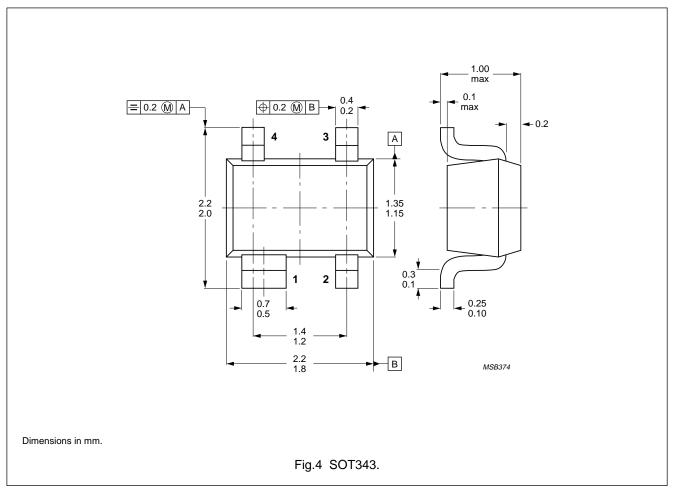
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#### PACKAGE OUTLINE



### BFG11W/X

#### DEFINITIONS

Data Sheet Status			
Objective specification	This data sheet contains target or goal specifications for product development.		
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.		
Product specification	This data sheet contains final product specifications.		
Limiting values			
Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.			

#### Application information

Where application information is given, it is advisory and does not form part of the specification.

#### LIFE SUPPORT APPLICATIONS

These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips for any damages resulting from such improper use or sale.